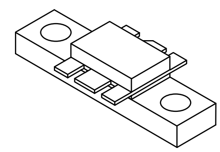
The RF Line
NPN Silicon RF Power Transistors

MRF891
MRF891S

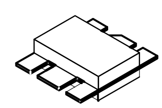
. . . designed for 24 volt UHF large–signal, common–emitter amplifier applications in industrial and commercial FM equipment operating in the range of 800–960 MHz.

- Specified 24 Volt, 900 MHz Characteristics
  Output Power = 5.0 Watts
  Power Gain = 9.0 dB Min
  Efficiency = 50% Min
- Series Equivalent Large–Signal Characterization
- Capable of Withstanding 20:1 VSWR Load Mismatch at Rated Output Power and Supply Voltage
- Gold Metallized, Emitter Ballasted for Long Life and Resistance to Metal Migration
- Silicon Nitride Passivated
- Circuit board photomaster available upon request by contacting RF Tactical Marketing in Phoenix, AZ.

**5.0 W, 900 MHz
RF POWER
TRANSISTORS
NPN SILICON**



**CASE 319–07, STYLE 2
MRF891**



**CASE 319A–02, STYLE 2
MRF891S**

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	V_{CEO}	30	Vdc
Collector–Emitter Voltage	V_{CES}	55	Vdc
Emitter–Base Voltage	V_{EBO}	4.0	Vdc
Collector Current — Continuous	I_C	0.6	Adc
Total Device Dissipation @ T_A = 50°C (1) Derate above 50°C	P_D	18 0.143	Watts W/°C
Storage Temperature Range	T_{stg}	–65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case (2)	$R_{\theta JC}$	7.0	°C/W

ELECTRICAL CHARACTERISTICS (T$_C$ = 25°C unless otherwise noted.)

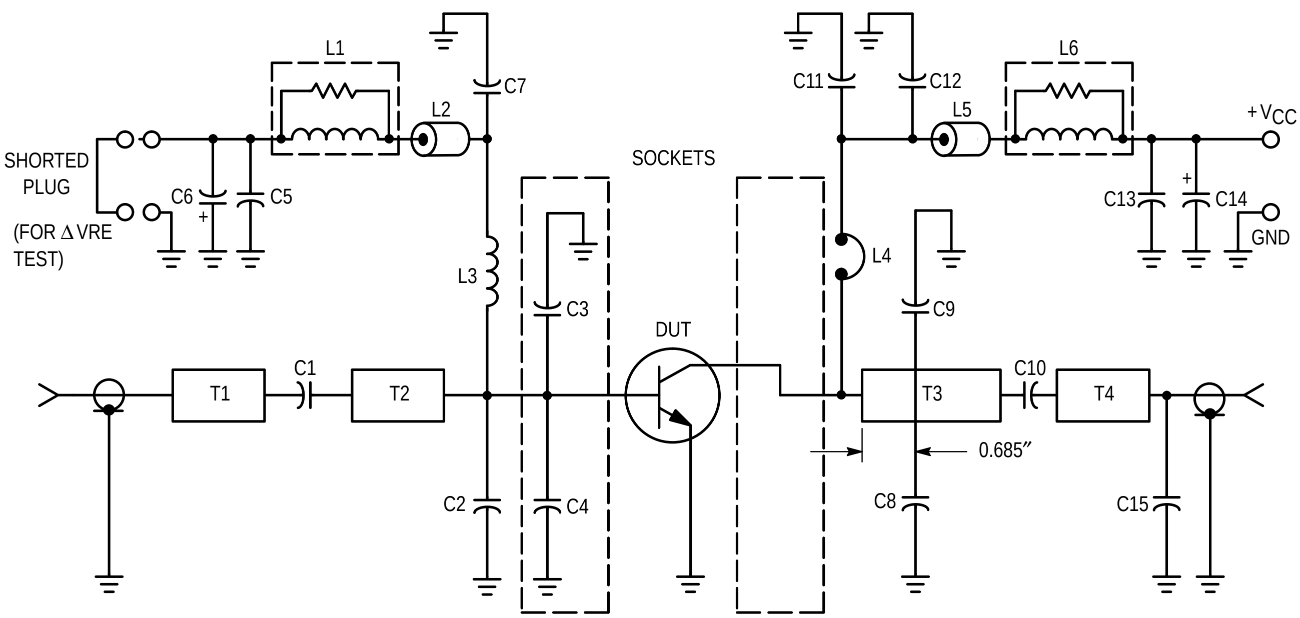
Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector–Emitter Breakdown Voltage (I_C = 20 mAdc, I_B = 0)	$V_{(BR)CEO}$	30	—	—	Vdc
Collector–Emitter Breakdown Voltage (I_C = 20 mAdc, V_{BE} = 0)	$V_{(BR)CES}$	55	—	—	Vdc
Emitter–Base Breakdown Voltage (I_E = 0.5 mAdc, I_C = 0)	$V_{(BR)EBO}$	4.0	—	—	Vdc
Collector Cutoff Current (V_{CE} = 30 Vdc, V_{BE} = 0, T_C = 25°C)	I_{CES}	—	—	1.0	mAdc
ON CHARACTERISTICS					
DC Current Gain (I_C = 200 mAdc, V_{CE} = 5.0 Vdc)	h_{FE}	30	—	150	—

NOTES:
1. This device is designed for RF operation. The total device dissipation rating applies only when the device is operated as an RF amplifier.
2. Thermal Resistance is determined under specified RF operating conditions by infrared measurement techniques.

(continued)

ELECTRICAL CHARACTERISTICS — continued (T_C = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
DYNAMIC CHARACTERISTICS					
Output Capacitance (V_{CB} = 24 Vdc, I_E = 0, f = 1.0 MHz)	C_{ob}	—	6.5	8.0	pF
FUNCTIONAL TESTS					
Common–Emitter Amplifier Power Gain (Broadband) (V_{CC} = 24 Vdc, P_{out} = 5.0 W, f = 900 MHz)	G_{pe}	9.0	10	—	dB
Collector Efficiency (V_{CC} = 24 Vdc, P_{out} = 5.0 W, f = 900 MHz)	η	50	57	—	%
Load Mismatch Stress (V_{CC} = 24 Vdc, P_{in} = 0.63 W, f = 900 MHz, VSWR = 20:1, all phase angles)	ψ	No Degradation in Output Power			



C1 — 39 pF, 100 Mil Chip Capacitor
C2, C8, C15 — 0.8–8.0 pF Johansen Gigatrim
C3, C4 — 12 pF, Mini–Unelco
C5, C13 — 1000 pF, 350 V Unelco
C6, C14 — 10 µF, 25 V Tantalum
C7, C11, C12 — 91 pF, Mini–Unelco
C9 — 5.0 pF, MIni–Unelco
C10 — 47 pF, 100 Mil Chip Capacitor

L1, L6 — 10 Turns #20 AWG Around 10 Ohm 1/2 Watt Resistor
L2, L5 — Ferrite Bead
L3 — 4 Turns #16 AWG Choke
L4 — 0.5″, #18 AWG Wire
T1, T4 — 50 Ohm Microstrip Line
T2 — W = 165 Mils, ℓ = 1946 Mils
T3 — W = 166 Mils, ℓ = 1563 Mils
PC Board — 0.031″ Glass Teflon (ε_r = 2.56)

Figure 1. Broadband Test Fixture

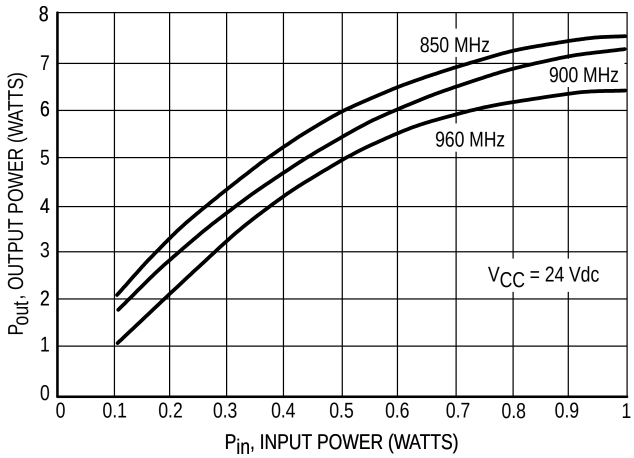


Figure 2. Output Power versus Input Power

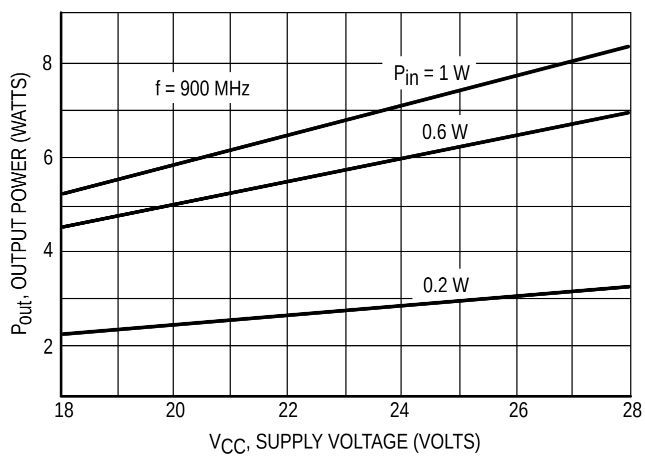


Figure 3. Output Power versus Supply Voltage

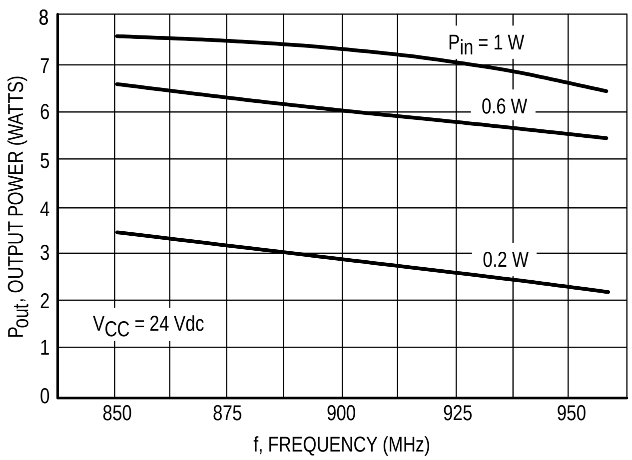


Figure 4. Output Power versus Frequency

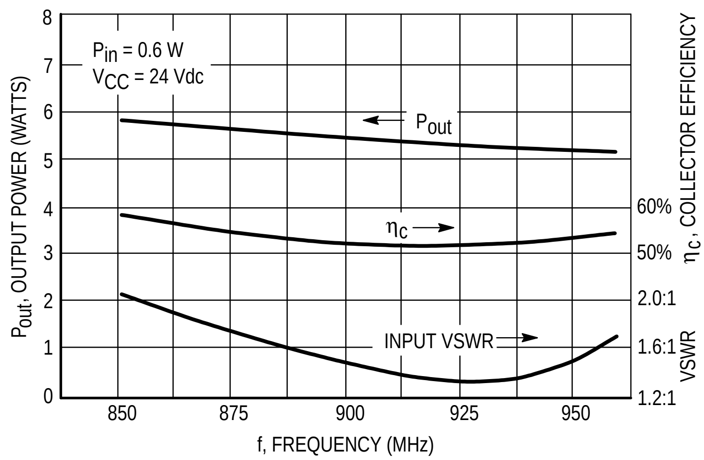


Figure 5. Typical Broadband Circuit Performance

V_{CC} = 24 Vdc, P_{out} = 5.0 W, Eff > 50%

f MHz	Z_{in} Ohms
850	1.1 + j3.0
900	1.0 + j3.25
960	1.18 + j3.5

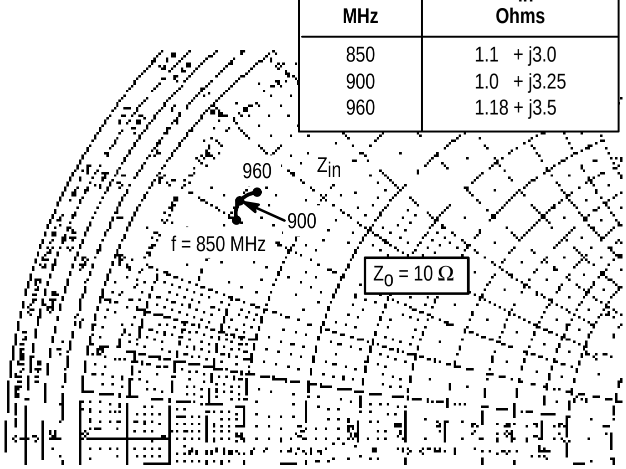


Figure 6. Series Equivalent Input Impedance

V_{CC} = 24 Vdc, P_{out} = 5.0 W, Eff > 50%

f MHz	Z_{OL}* Ohms
850	8.34 – j13.2
900	9.1 – j13.8
960	10.4 – j14.6

Z_{OL}* = Conjugate of the optimum load impedance into which the device output operates at a given output power, voltage and frequency.

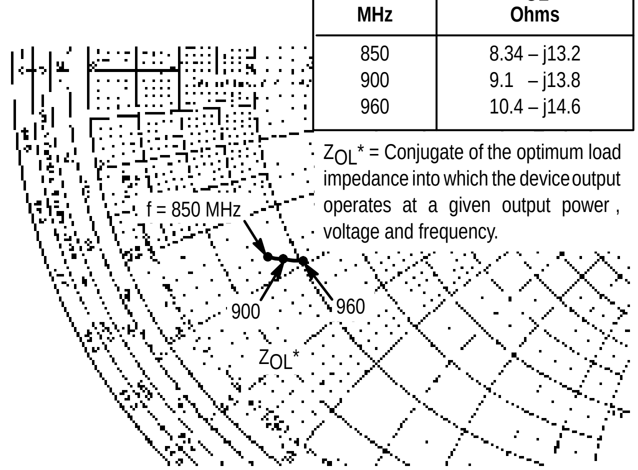
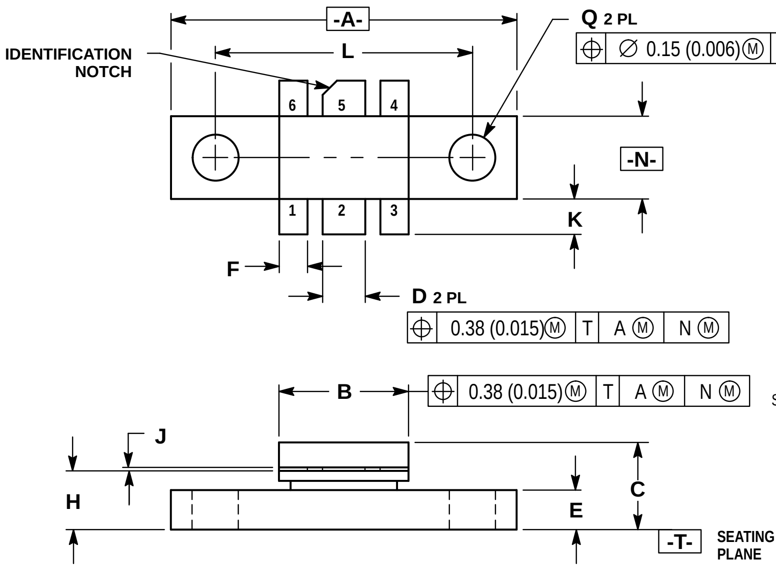


Figure 7. Series Equivalent Output Impedance

PACKAGE DIMENSIONS

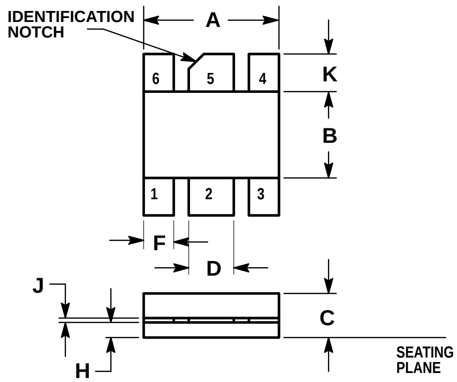


NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES MIN	INCHES MAX	MILLIMETER MIN	MILLIMETER MAX
A	0.965	0.985	24.52	25.01
B	0.355	0.375	9.02	9.52
C	0.230	0.260	5.85	6.60
D	0.115	0.125	2.93	3.17
E	0.102	0.114	2.59	2.90
F	0.075	0.085	1.91	2.15
H	0.160	0.170	4.07	4.31
J	0.004	0.006	0.11	0.15
K	0.090	0.110	2.29	2.79
L	0.725 BSC		18.42 BSC	
N	0.225	0.241	5.72	6.12
Q	0.125	0.135	3.18	3.42

STYLE 2:
PIN 1. EMITTER (COMMON)
2. BASE (INPUT)
3. EMITTER (COMMON)
4. EMITTER (COMMON)
5. COLLECTOR (OUTPUT)
6. EMITTER (COMMON)

CASE 319–07
ISSUE M
MRF891



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES MIN	INCHES MAX	MILLIMETERS MIN	MILLIMETERS MAX
A	0.355	0.365	9.02	9.27
B	0.225	0.235	5.72	5.96
C	0.110	0.125	2.80	3.17
D	0.115	0.125	2.93	3.17
F	0.075	0.085	1.91	2.15
H	0.035	0.045	0.89	1.14
J	0.004	0.006	0.11	0.15
K	0.090	0.110	2.29	2.79

STYLE 2:
PIN 1. EMITTER
2. BASE
3. EMITTER
4. EMITTER
5. COLLECTOR
6. EMITTER

CASE 319A–02
ISSUE B
MRF891S

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